

74AC20 Dual 4-Input NAND Gate

General Description

The AC20 contains four 4-input NAND gates.

Features

- I_{CC} reduced by 50%
- Outputs source/sink 24 mA

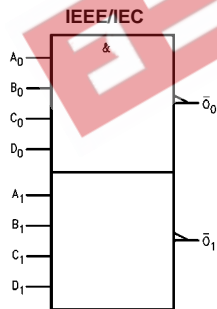
Ordering Code:

Order Number	Package Number	Package Description
74AC20SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74AC20SJ	M14D	Pb-Free 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74AC20MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74AC20MTC_NL (Note 1)	MTC14	Pb-Free 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74AC20PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

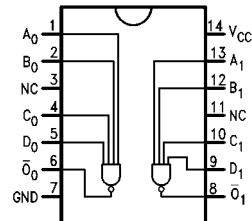
Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.
Pb-Free package per JEDEC J-STD-020B.

Note 1: "_NL" indicates Pb-Free package (per JEDEC J-STD-020B).

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description
A _n , B _n , C _n , D _n	Inputs
\bar{O}_n	Outputs

FACT™ is a trademark of Fairchild Semiconductor Corporation.

Absolute Maximum Ratings (Note 2)		Recommended Operating Conditions	
Supply Voltage (V_{CC})	-0.5V to +7.0V	Supply Voltage (V_{CC})	2.0V to 6.0V
DC Input Diode Current (I_{IK})		Input Voltage (V_I)	0V to V_{CC}
$V_I = -0.5V$	-20 mA	Output Voltage (V_O)	0V to V_{CC}
$V_I = V_{CC} + 0.5V$	+20 mA	Operating Temperature (T_A)	-40°C to +85°C
DC Input Voltage (V_I)	-0.5V to $V_{CC} + 0.5V$	Minimum Input Edge Rate ($\Delta V/\Delta t$)	125 mV/ns
DC Output Diode Current (I_{OK})		V_{IN} from 30% to 70% of V_{CC}	
$V_O = -0.5V$	-20 mA	V_{CC} @ 3.3V, 4.5V, 5.5V	
$V_O = V_{CC} + 0.5V$	+20 mA		
DC Output Voltage (V_O)	-0.5V to $V_{CC} + 0.5V$		
DC Output Source or Sink Current (I_O)	± 50 mA		
DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})	± 50 mA		
Storage Temperature (T_{STG})	-65°C to +150°C		
Junction Temperature (T_J)			
PDIP	140°C		

Note 2: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = +25^\circ\text{C}$		$T_A = -40^\circ\text{C to } +85^\circ\text{C}$		Units	Conditions
			Typ	Guaranteed Limits	Typ	Guaranteed Limits		
V_{IH}	Minimum HIGH Level Input Voltage	3.0	1.5	2.1	2.1	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		4.5	2.25	3.15	3.15			
		5.5	2.75	3.85	3.85			
V_{IL}	Maximum LOW Level Input Voltage	3.0	1.5	0.9	0.9	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		4.5	2.25	1.35	1.35			
		5.5	2.75	1.65	1.65			
V_{OH}	Minimum HIGH Level Output Voltage	3.0	2.99	2.9	2.9	V	$I_{OUT} = -50 \mu\text{A}$	
		4.5	4.49	4.4	4.4			
		5.5	5.49	5.4	5.4			
			3.0		2.56	2.46	V	$V_{IN} = V_{IL}$ or V_{IH} $I_{OH} = -12 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ (Note 3)
			4.5		3.86	3.76		
			5.5		4.86	4.76		
V_{OL}	Maximum LOW Level Output Voltage	3.0	0.002	0.1	0.1	V	$I_{OUT} = 50 \mu\text{A}$	
		4.5	0.001	0.1	0.1			
		5.5	0.001	0.1	0.1			
		3.0		0.36	0.44	V	$V_{IN} = V_{IL}$ or V_{IH} $I_{OL} = 12 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ (Note 3)	
		4.5		0.36	0.44			
		5.5		0.36	0.44			
I_{IN} (Note 5)	Maximum Input Leakage Current	5.5		± 0.1	± 1.0	μA	$V_I = V_{CC}, \text{ GND}$	
I_{OLD}	Minimum Dynamic	5.5			75	mA	$V_{OLD} = 1.65V \text{ Max}$	
I_{OHD}	Output Current (Note 4)	5.5			-75	mA	$V_{OHD} = 3.85V \text{ Min}$	
I_{CC} (Note 5)	Maximum Quiescent Supply Current	5.5		2.0	20.0	μA	$V_{IN} = V_{CC}$ or GND	

Note 3: All outputs loaded; thresholds on input associated with output under test.

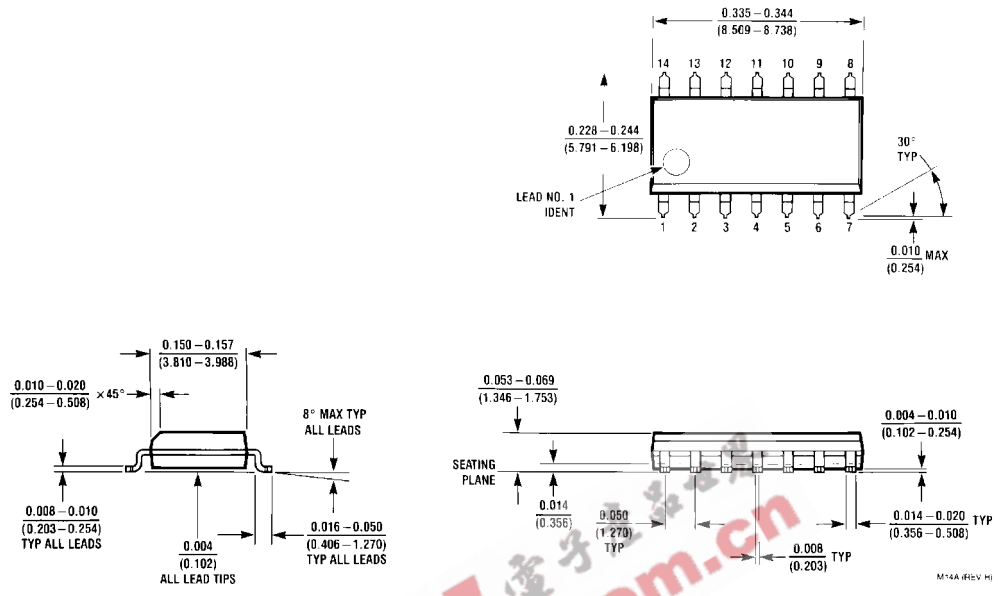
Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

AC Electrical Characteristics								
Symbol	Parameter	V _{CC} (V) (Note 6)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
t _{PLH}	Propagation Delay	3.3	2.0	6.0	8.5	1.5	10.0	ns
		5.0	1.5	5.0	7.0	1.0	8.0	
t _{PHL}	Propagation Delay	3.3	1.5	5.0	7.0	1.0	9.0	ns
		5.0	1.5	4.0	6.0	1.0	7.0	
Note 6: Voltage Range 3.3 is 3.3V ± 0.3V Voltage Range 5.0 is 5.0V ± 0.5V								
Capacitance								
Symbol	Parameter	Typ	Units	Conditions				
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN				
C _{PD}	Power Dissipation Capacitance	40.0	pF	V _{CC} = 5.0V				

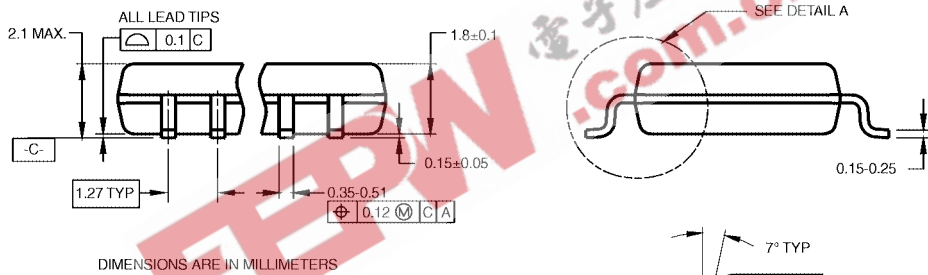
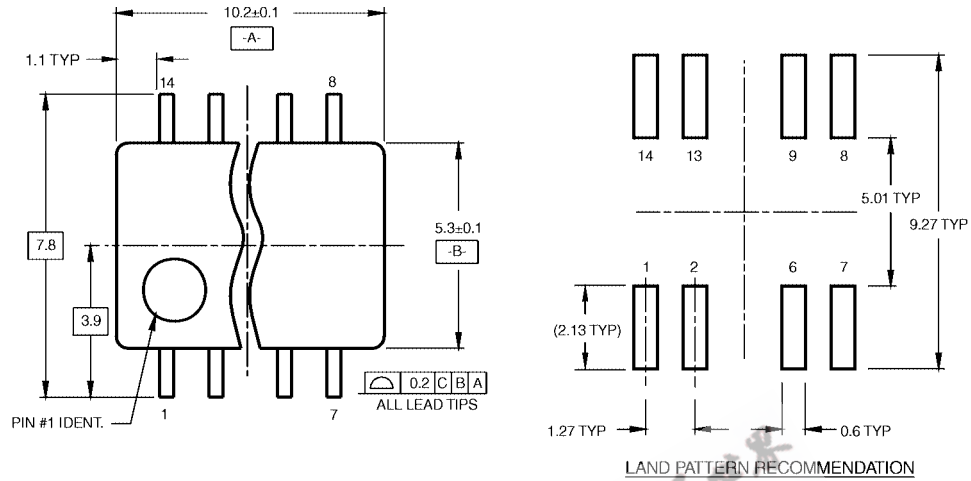
EEPW 电子产品世界
www.fairchildsemi.com.cn

Physical Dimensions inches (millimeters) unless otherwise noted



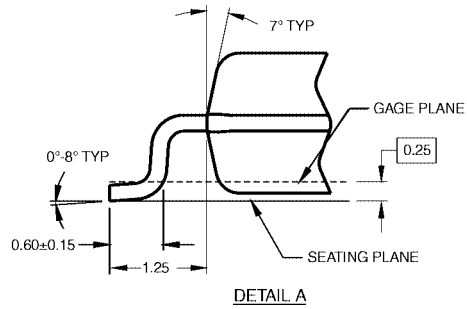
14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
Package Number M14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



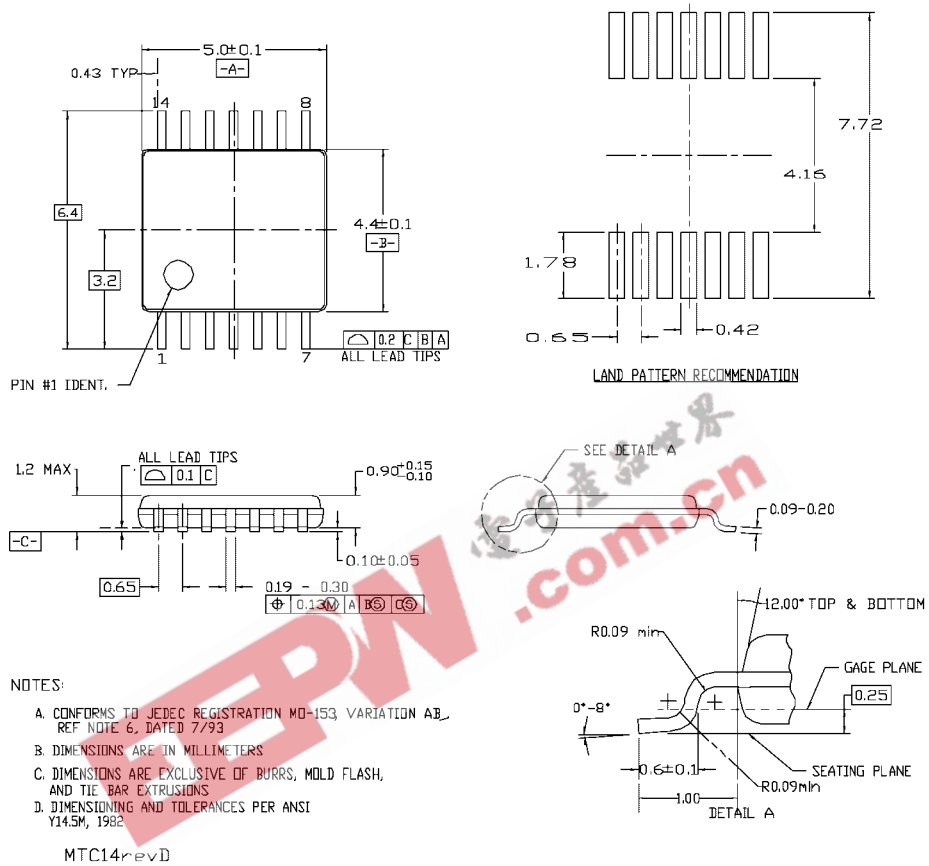
- NOTES:
 A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998.
 B. DIMENSIONS ARE IN MILLIMETERS.
 C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

M14DRevB1



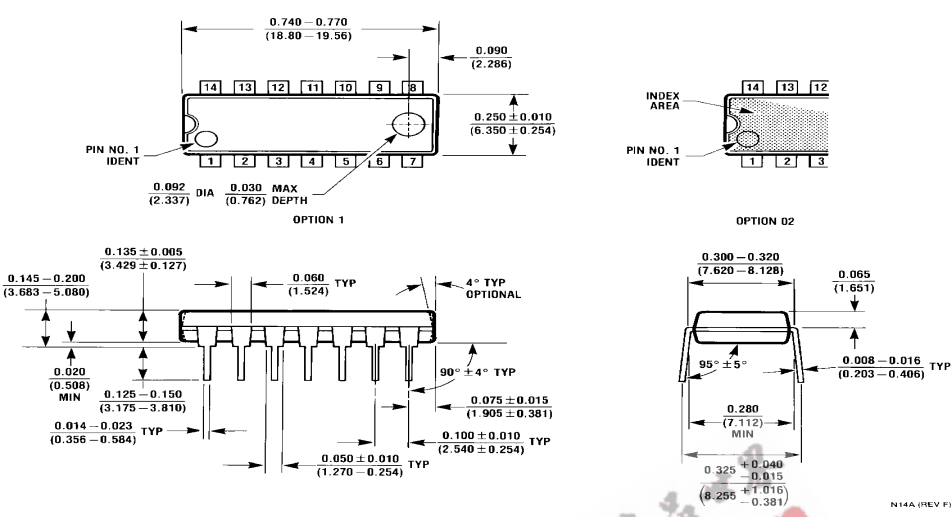
Pb-Free 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M14D

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC14

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N14A**

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com